

**Influence of severe straining and strain rate on the evolution of dislocation structures during micro-/nanoindentation in high entropy lamellar eutectics**

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**Study of surface defects in 4H-SiC Schottky diodes using a scanning Kelvin probe**

Mizsei, Janos; **Korolkov, Oleg; Toompuu, Jana; Mikli, Valdek; Rang, Toomas** Silicon Carbide and Related Materials 2012 : selected peer reviewed papers from the 9th European Conference on Silicon Carbide and Related Materials (ECSCRM 2012), September 2-6, 2012, St. Petersburg, Russian Federation 2013 / p. 677-680 : ill